

## **Search Notes**



**Application/Control No.**

10/611,295

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**Examiner**

Joseph M. Pelham

**Applicant(s)/Patent under  
Reexamination**

SHEI, STEVEN M.

## Art Unit

3742

SEARCHED

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner